

Search Notes**Application/Control No.**

10/529,804

**Applicant(s)/Patent under
Reexamination**

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Examiner

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Art Unit

1793

SEARCHED

Class	Subclass	Date	Examiner
148	433		
420	472		
	473		
	475	5/11/2008	SI

INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner

**SEARCH NOTES
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
STN		
eDAN inventor name searched	5/11/2008	SI